# Dual SPST Analog Switch, Low Voltage, Single Supply

The NLAS323 is a dual SPST (Single Pole, Single Throw) switch, similar to 1/2 a standard 4066. The device permits the independent selection of 2 analog/digital signals. Available in the Ultra–Small 8 package.

The use of advanced 0.6  $\mu$  CMOS process, improves the  $R_{ON}$  resistance considerably compared to older higher voltage technologies.

- On Resistance is 20 Ω Typical at 5.0 V
- Matching is  $< 1 \Omega$  Between Sections
- 2 6 V Operating Range
- Ultra Low < 5 pC Charge Injection
- Ultra Low Leakage < 1 nA at 5.0 V, 25 C
- Wide Bandwidth > 200 MHz, -3 dB
- CMOS/TTL Compatible
- 2000 V ESD (HBM)
- Ron Flatness  $+/-6 \Omega$  at 5.0 V
- US8 Package
- Independent, Positive Enable

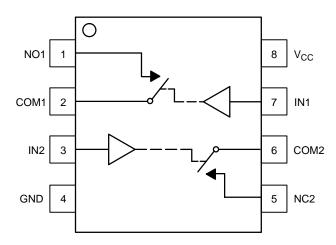


Figure 1. Pinout



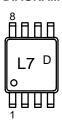
## ON Semiconductor™

http://onsemi.com

MARKING DIAGRAM



US8 US SUFFIX CASE 493



L7 = Device Code D = Date Code

## **PIN ASSIGNMENT**

1	NC1
2	COM1
3	IN2
4	GND
5	NC2
6	COM2
7	IN1
8	V <sub>CC</sub>

#### **FUNCTION TABLE**

On/Off Enable Input	State of Analog Switch
L	Off
Н	On

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 9 of this data sheet.

## **MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit	
V <sub>CC</sub>	DC Supply Voltage		-0.5  to  +7.0	V
V <sub>I</sub>	DC Input Voltage		-0.5  to  +7.0	V
Vo	DC Output Voltage		-0.5  to  +7.0	V
I <sub>IK</sub>	DC Input Diode Current	V <sub>I</sub> < GND	-50	mA
I <sub>OK</sub>	DC Output Diode Current	V <sub>O</sub> < GND	-50	mA
I <sub>O</sub>	DC Output Sink Current		±50	mA
I <sub>CC</sub>	DC Supply Current per Supply Pin		±100	mA
I <sub>GND</sub>	DC Ground Current per Ground Pin		±100	mA
T <sub>STG</sub>	Storage Temperature Range		-65 to +150	°C
TL	Lead Temperature, 1 mm from Case for 10 Second	ls	260	°C
TJ	Junction Temperature under Bias		+150	°C
$\theta_{JA}$	Thermal Resistance	(Note 1)	250	°C/W
P <sub>D</sub>	Power Dissipation in Still Air at 85°C		250	mW
MSL	Moisture Sensitivity		Level 1	
F <sub>R</sub>	Flammability Rating	Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in	
V <sub>ESD</sub>	ESD Withstand Voltage	Human Body Model (Note 2) Machine Model (Note 3) Charged Device Model (Note 4)	> 2000 > 150 N/A	V

Maximum Ratings are those values beyond which damage to the device may occur. Exposure to these conditions or conditions beyond those indicated may adversely affect device reliability. Functional operation under absolute maximum–rated conditions is not implied. Functional operation should be restricted to the Recommended Operating Conditions.

- 1. Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2-ounce copper trace with no air flow.
- 2. Tested to EIA/JESD22-A114-A.
- 3. Tested to EIA/JESD22-A115-A.
- 4. Tested to JESD22-C101-A.

## RECOMMENDED OPERATING CONDITIONS

Symbol	Characteristics	Min	Max	Unit	
V <sub>CC</sub>	Positive DC Supply Voltage	2.0	5.5	V	
V <sub>IN</sub>	Digital Input Voltage (Enable)	GND	5.5	V	
V <sub>IO</sub>	Static or Dynamic Voltage Across an Off Switch	GND	V <sub>CC</sub>	V	
V <sub>IS</sub>	Analog Input Voltage (NO, COM)		GND	V <sub>CC</sub>	V
T <sub>A</sub>	Operating Temperature Range, All Package Types		<b>-</b> 55	+125	°C
t <sub>r</sub> , t <sub>f</sub>	Input Rise or Fall Time, (Enable Input)	$V_{cc} = 3.3 \text{ V} \pm 0.3 \text{ V}$ $V_{cc} = 5.0 \text{ V} \pm 0.5 \text{ V}$	0 0	100 20	ns/V

# DEVICE JUNCTION TEMPERATURE VERSUS TIME TO 0.1% BOND FAILURES

TO STI 70 BOND I 70LONES								
Junction Temperature °C	Time, Hours	Time, Years						
80	1,032,200	117.8						
90	419,300	47.9						
100	178,700	20.4						
110	79,600	9.4						
120	37,000	4.2						
130	17,800	2.0						
140	8,900	1.0						

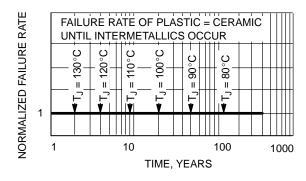


Figure 2. Failure Rate vs. Time Junction Temperature

## DC CHARACTERISTICS – Digital Section (Voltages Referenced to GND)

				Guaranteed Max Limit			
Symbol	Parameter	Condition	V <sub>CC</sub>	–55 to 25°C	<85°C	<125°C	Unit
V <sub>IH</sub>	Minimum High-Level Input Voltage, Enable Inputs		2.0 3.0 4.5 5.5	1.5 2.1 3.15 3.85	1.5 2.1 3.15 3.85	1.5 2.1 3.15 3.85	V
V <sub>IL</sub>	Maximum Low-Level Input Voltage, Enable Inputs		2.0 3.0 4.5 5.5	0.5 0.9 1.35 1.65	0.5 0.9 1.35 1.65	0.5 0.9 1.35 1.65	V
I <sub>IN</sub>	Maximum Input Leakage Current, Enable Inputs	V <sub>IN</sub> = 5.5 V or GND	0 V to 5.5 V	<u>+</u> 0.1	<u>+</u> 1.0	<u>+</u> 1.0	μΑ
Icc	Maximum Quiescent Sup- ply Current (per package)	Enable and VIS = VCC or GND	5.5	1.0	1.0	2.0	μΑ

## DC ELECTRICAL CHARACTERISTICS - Analog Section

				Guara	inteed Max L	imit.	
Symbol	Parameter	Condition	Vcc	−55 to 25°C	<85°C	<125°C	Unit
R <sub>ON</sub>	Maximum ON Resistance (Figures 8 – 12)	$V_{IN} = V_{IH}$ $V_{IS} = V_{CC} \text{ to GND}$ $I_{IS}I = \leq 10.0 \text{mA}$	3.0 4.5 5.5	45 30 25	50 35 30	55 40 35	Ω
R <sub>FLAT(ON)</sub>	ON Resistance Flatness	$V_{IN} = V_{IH}$ $I_{IS}I = \le 10.0 \text{mA}$ $V_{IS} = 1V, 2V, 3.5V$	4.5	4	4	5	Ω
I <sub>NO(OFF)</sub>	Off Leakage Current, Pin 2 (Figure 3)	$V_{IN} = V_{IL}$ $V_{NO} = 1.0 \text{ V}, V_{COM} = 4.5 \text{ V or}$ $V_{COM} = 1.0 \text{ V and } V_{NO} 4.5 \text{ V}$	5.5	1	10	100	nA
I <sub>COM(OFF)</sub>	Off Leakage Current, Pin 1 (Figure 3)	V <sub>IN</sub> = V <sub>IL</sub> V <sub>NO</sub> = 4.5 V or 1.0 V V <sub>COM</sub> = 1.0 V or 4.5 V	5.5	1	10	100	nA

## AC ELECTRICAL CHARACTERISTICS (Input $t_f$ = $t_f$ = 3.0 ns)

					Guaranteed Max Limit								
			V <sub>CC</sub>	-5	5 to 25	s°C		<85°C			<125°C	;	
Symbol	Parameter	Test Conditions	(V)	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
t <sub>ON</sub>	Turn-On Time	$R_L = 300 \Omega$ , $C_L = 35 pF$ (Figures 4, 5, and 13)	2.03 .04. 55.5		7.0 5.0 4.5 4.5	14 10 9 9			16 12 11 11			16 12 11 11	ns
t <sub>OFF</sub>	Turn-Off Time	$R_L = 300 \Omega$ , $C_L = 35 pF$ (Figures 4, 5, and 13)	2.03 .04. 5 5.5		11.0 7.0 5.0 5.0	22 14 10 10			24 16 12 12			24 16 12 12	ns

		Typical @ 25, VCC = 5.0 V	
C <sub>IN</sub>	Maximum Input Capacitance, Select Input	8	pF
C <sub>NO or</sub> C <sub>NC</sub>	Analog I/O (switch off)	10	
C <sub>COM(OFF)</sub>	Common I/O (switch off)	10	
C <sub>COM(ON)</sub>	Feedthrough (switch on)	20	

## ADDITIONAL APPLICATION CHARACTERISTICS (Voltages Referenced to GND Unless Noted)

			V <sub>CC</sub>	Limit	
Symbol	Parameter	Condition	V	25°C	Unit
BW	Maximum On–Channel –3dB Bandwidth or Minimum Frequency Response	$V_{IS}$ = 0 dBm $V_{IS}$ centered between $V_{CC}$ and GND (Figures 6 and 14)	3.0 4.5 5.5	190 200 220	MHz
VonL	Maximum Feedthrough On Loss	V <sub>IS</sub> = 0 dBm @ 10 kHz V <sub>IS</sub> centered between V <sub>CC</sub> and GND (Figure 6)	3.0 4.5 5.5	-2 -2 -2	dB
V <sub>ISO</sub>	Off-Channel Isolation	$f$ = 100 kHz; $V_{IS}$ = 1 V RMS $V_{IS}$ centered between $V_{CC}$ and GND (Figures 6 and 15)	3.0 4.5 5.5	-93	dB
Q	Charge Injection Enable Input to Common I/O	$\begin{aligned} &V_{IS} = V_{CC\ to}\ GND,\ F_{IS} = 20\ kHz\\ &t_r = t_f = 3\ ns\\ &R_{IS} = 0\ \Omega,\ C_L = 1000\ pF\\ &Q = C_L * \Delta V_{OUT}\\ &(Figures\ 6\ and\ 16) \end{aligned}$	3.0 5.5	1.5 3.0	рС
THD	Total Harmonic Distortion THD + Noise	$F_{IS} = 20 \text{ Hz to 1 MHz}, \ R_L = Rgen = 600 \ \Omega, \ C_L = 50 \ pF$ $V_{IS} = 3.0 \ V_{PP} \ sine \ wave$ $V_{IS} = 5.0 \ V_{PP} \ sine \ wave$ (Figure 17)	3.3 5.5	0.3 0.15	%

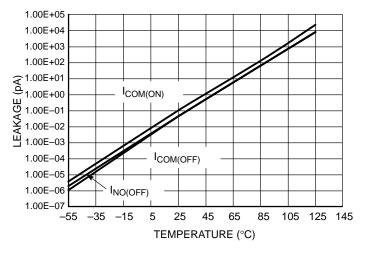
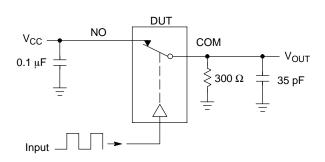


Figure 3. Switch Leakage vs. Temperature



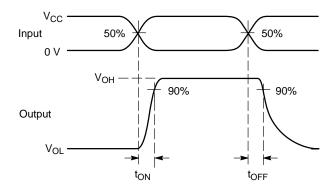
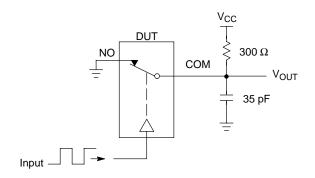


Figure 4. t<sub>ON</sub>/t<sub>OFF</sub>



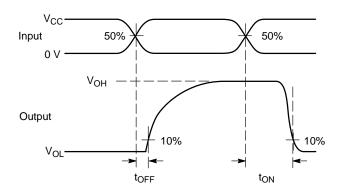
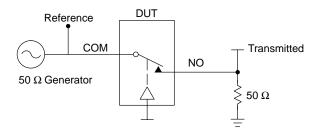


Figure 5. t<sub>ON</sub>/t<sub>OFF</sub>



Channel switch control/s test socket is normalized. Off isolation is measured across an off channel. On loss is the bandwidth of an On switch.  $V_{\rm ISO}$ , Bandwidth and  $V_{\rm ONL}$  are independent of the input signal direction.

$$\begin{split} &V_{ISO} = \text{Off Channel Isolation} = 20 \text{ Log } \left( \frac{\text{VOUT}}{\text{VIN}} \right) \text{ for V}_{IN} \text{ at } 100 \text{ kHz} \\ &V_{ONL} = \text{On Channel Loss} = 20 \text{ Log } \left( \frac{\text{VOUT}}{\text{VIN}} \right) \text{ for V}_{IN} \text{ at } 100 \text{ kHz to } 50 \text{ MHz} \end{split}$$

Bandwidth (BW) = the frequency 3 dB below V<sub>ONL</sub>

Figure 6. Off Channel Isolation/On Channel Loss (BW)/Crosstalk (On Channel to Off Channel)/V<sub>ONL</sub>

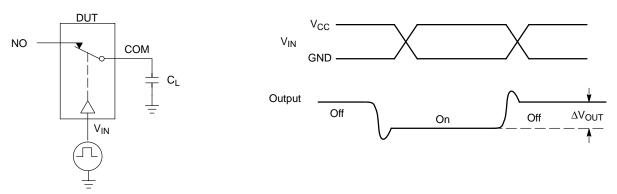


Figure 7. Charge Injection: (Q)

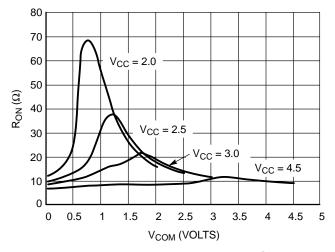


Figure 8.  $R_{ON}$  vs.  $V_{COM}$  and  $V_{CC}$  (@25°C)

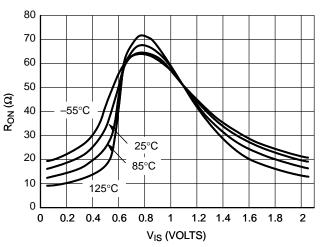


Figure 9.  $R_{\mbox{\scriptsize ON}}$  vs.  $V_{\mbox{\scriptsize COM}}$  and Temperature,  $V_{\mbox{\scriptsize CC}} = 2.0~\mbox{\scriptsize V}$ 

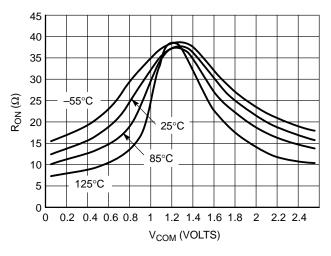


Figure 10.  $R_{ON}$  vs.  $V_{COM}$  and Temperature,  $V_{CC}$  = 2.5 V

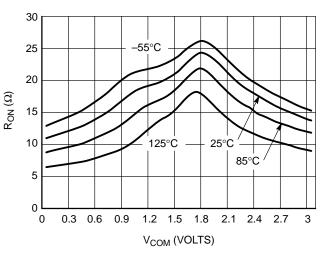


Figure 11. R<sub>ON</sub> vs. V<sub>COM</sub> and Temperature, V<sub>CC</sub> = 3.0 V

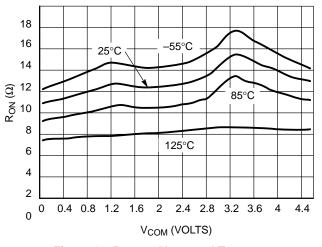


Figure 12.  $R_{ON}$  vs.  $V_{COM}$  and Temperature,  $V_{CC}$  = 4.5 V

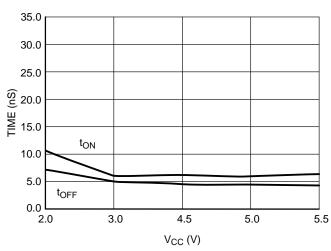


Figure 13. Switching Time vs. Supply Voltage,  $T = 25^{\circ}C$ 

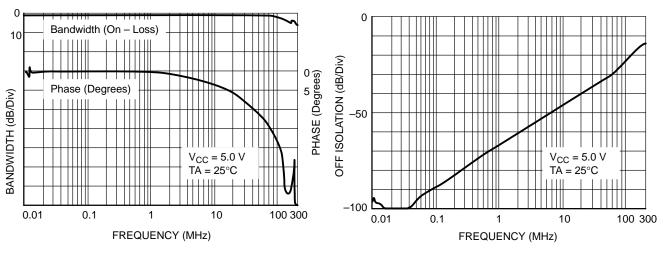


Figure 14. ON Channel Bandwidth and Phase Shift Over Frequency

Figure 15. Off Channel Isolation

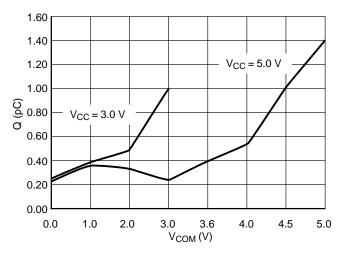


Figure 16. Charge Injection vs. V<sub>COM</sub>

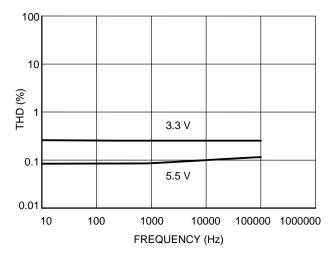


Figure 17. THD vs. Frequency

## **DEVICE ORDERING INFORMATION**

		Device Nome	enclature			
Device Order Number	Circuit Indicator	Technology	Device Function	Package Suffix	Package Type	Tape and Reel Size
NLAS323US	NL	AS	323	US	US8	178 mm (7") 3000 Unit

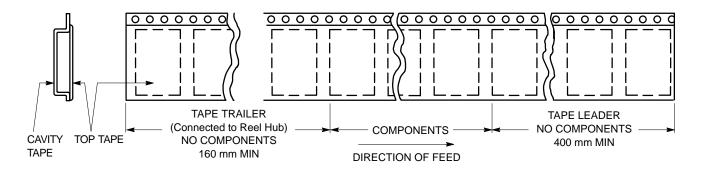


Figure 18. Tape Ends for Finished Goods

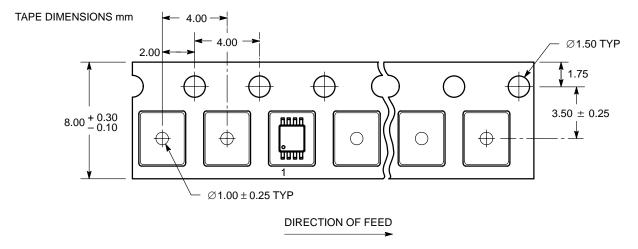


Figure 19. US8 Reel Configuration/Orientation

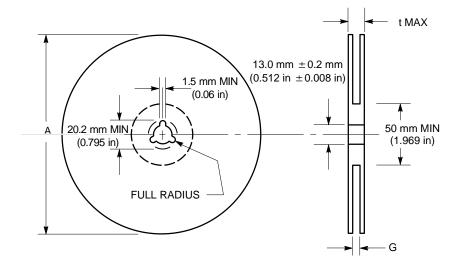


Figure 20. Reel Dimensions

## **REEL DIMENSIONS**

Tape Size	T and R Suffix	A Max	G	t Max
8 mm	US	178 mm (7 in)	8.4 mm, + 1.5 mm, -0.0 (0.33 in + 0.059 in, -0.00)	14.4 mm (0.56 in)

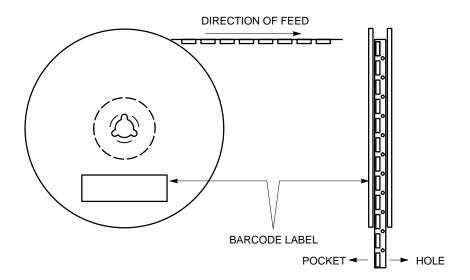
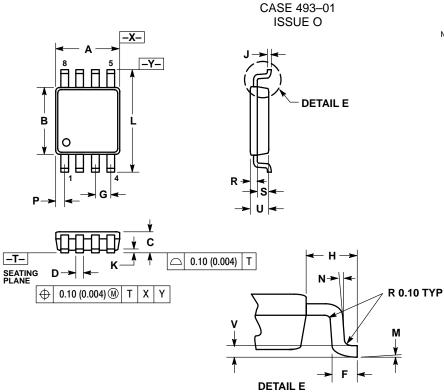


Figure 21. Reel Winding Direction

## **PACKAGE DIMENSIONS**

# US8 **US SUFFIX**



- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

  2. CONTROLLING DIMENSION: MILLIMETERS

  3. DIMENSION "A" DOES NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURR. MOLD FLASH. PROTRUSION AND GATE BURR SHALL NOT EXCEED 0.140 MM (0.0055") PER SIDE.

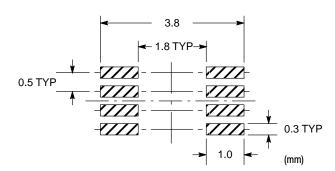
  4. DIMENSION "B" DOES NOT INCLUDE INTER-LEAD FLASH OR PROTRUSION. INTER-LEAD FLASH AND PROTRUSION SHALL NOT E3XCEED 0.140 (0.0055") PER SIDE.

  5. LEAD FINISH IS SOLDER PLATING WITH THICKNESS OF 0.0076-0.0203 MM. (300-800 INCH).

- INCH).

  6. ALL TOLERANCE UNLESS OTHERWISE SPECIFIED ±0.0508 (0.0002").

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	1.90	2.10	0.075	0.083
В	2.20	2.40	0.087	0.094
С	0.60	0.90	0.024	0.035
D	0.17	0.25	0.007	0.010
F	0.20	0.35	0.008	0.014
G	0.50 BSC		0.020 BSC	
Н	0.40 REF		0.016 REF	
J	0.10	0.18	0.004	0.007
K	0.00	0.10	0.000	0.004
L	3.00	3.20	0.118	0.126
M	0 °	6 °	0 °	6°
N	5 °	10 °	5 °	10 °
P	0.28	0.44	0.011	0.017
R	0.23	0.33	0.009	0.013
S	0.37	0.47	0.015	0.019
U	0.60	0.80	0.024	0.031
٧	0.12 BSC		0.005 BSC	



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